L4 SERIES

1. PART NO. EXPRESSION:

L 4 - 4 7 N K - 1 0

(a) Series code

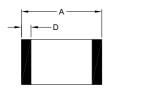
(d) 10 : Lead Free

(a) (b) (c) (d)

(b) Inductance code : 47N = 0.047uH

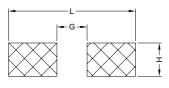
(c) Tolerance code : $K = \pm 10\%$, $M = \pm 20\%$

2. CONFIGURATION & DIMENSIONS:









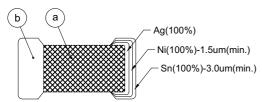
PCB Pattern

Unit:m/m

Α	В	С	D	G	Н	L
3.20±0.20	1.60±0.20	1.10±0.30	0.50±0.30	2.20 Ref.	1.40 Ref.	4.40 Ref.

3. SCHEMATIC:

4. MATERIALS:



(a) Body : Ferrite

(b) Termination : Ag/Ni/Sn

5. GENERAL SPECIFICATION:

a) Temp. rise: 30°C Max.

b) Rated current: Base on temp. rise
c) Storage temp.: -40°C to +85°C
d) Operating temp.: -40°C to +85°C

e) Resistance to solder heat: 260°C.10secs

RoHS Compliant

NOTE: Specifications subject to change without notice. Please check our website for latest information.



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6. ELECTRICAL CHARACTERISTICS:

Part Number	EIA Size	Inductance (µH)	Q Min	Test Frequency (MHz)	SRF (MHz) Min.	DC Resistance (Ω) Max.	Rated Current (mA)
L4-47N -10	1206	0.047	20	50	320	0.15	300
L4-68N -10	1206	0.068	20	50	280	0.25	300
L4-R10 -10	1206	0.100	20	25	235	0.25	250
L4-R12 -10	1206	0.120	20	25	220	0.30	250
L4-R15 -10	1206	0.150	20	25	200	0.30	250
L4-R18 -10	1206	0.180	20	25	185	0.40	250
L4-R22 -10	1206	0.220	20	25	170	0.40	250
L4-R27 -10	1206	0.270	20	25	150	0.50	250
L4-R33 -10	1206	0.330	20	25	145	0.50	250
L4-R39 -10	1206	0.390	25	25	135	0.60	250
L4-R47 -10	1206	0.470	25	25	125	0.60	200
L4-R56 -10	1206	0.560	25	25	115	0.70	200
L4-R68 -10	1206	0.680	25	25	105	0.80	150
L4-R82 -10	1206	0.820	25	25	100	0.90	150
L4-1R0 -10	1206	1.000	45	10	75	0.40	100
L4-1R2 -10	1206	1.200	45	10	65	0.50	100
L4-1R5 -10	1206	1.500	45	10	60	0.50	50
L4-1R8 -10	1206	1.800	45	10	55	0.50	50
L4-2R2 -10	1206	2.200	45	10	50	0.60	50
L4-2R7 -10	1206	2.700	45	10	45	0.60	50
L4-3R3 -10	1206	3.300	45	10	41	0.70	50
L4-3R9 -10	1206	3.900	45	10	38	0.80	50
L4-4R7 -10	1206	4.700	45	10	35	0.90	50
L4-5R6 -10	1206	5.600	50	4	32	0.70	25
L4-6R8 -10	1206	6.800	50	4	29	0.80	25
L4-8R2 -10	1206	8.200	50	4	26	0.90	25
L4-100 -10	1206	10.000	50	2	24	1.00	25
L4-120 -10	1206	12.000	50	2	22	1.05	15
L4-150 -10	1206	15.000	35	1	19	0.70	5
L4-180 -10	1206	18.000	35	1	18	070	5
L4-220 -10	1206	22.000	35	1	16	0.90	5
L4-270 -10	1206	27.000	35	1	14	0.90	5
L4-330 -10	1206	33.000	35	0.4	13	1.05	5

Inductance tolerance :

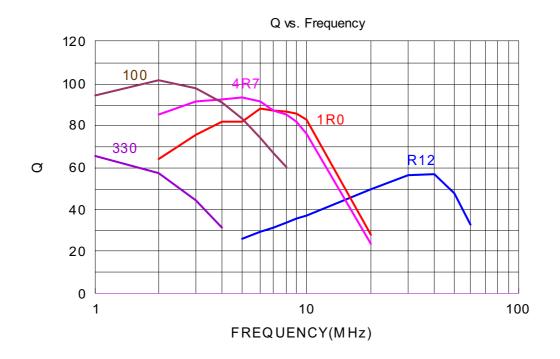
: K : ±10% M : ±20% RoHS Compliant

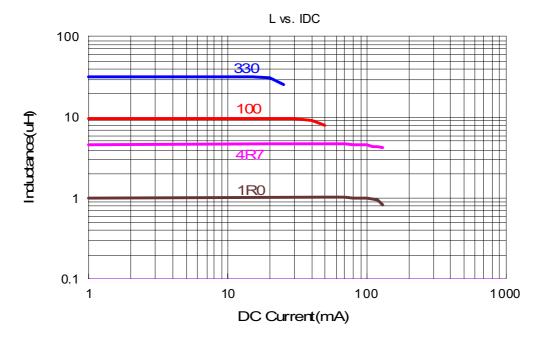
 ${\it NOTE}$: Specifications subject to change without notice. Please check our website for latest information.



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7. IMPEDANCE VS. FREQUENCY CURVES:







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8. RELIABILITY & TEST CONDITION:

ITEM	PERFORMANCE	TEST CONDITION				
Electrical Characteristics Tes	t					
Impedance		HP4291A, HP4287A+16092A				
DC Resistance	Refer to standard electrical characteristics list	HP4338B				
Rated Current						
Temperature Rise Test	30°C max. (Δt)	Applied the allowed DC current. Temperature measured by digital surface thermometer.				
Solder Heat Resistance	No mechanical damage Remaining terminal electrode : 70% min. 260°C Preheating Dipping Natural cooling 150°C 60 seconds 10±0.5 seconds	Preheat: 150°C, 60sec. Solder: Sn-Ag3.0-Cu0.5 Solder Temperature: 260±5°C Flux for lead free: rosin Dip Time: 10±0.5sec.				
Solderability	More than 90% of the terminal electrode should be covered with solder. Preheating Dipping Natural cooling 150°C 150°C 4±1.0 seconds	Preheat: 150°C, 60sec. Solder: Sn-Ag3.0-Cu0.5 Solder Temperature: 245±5°C Flux for lead free: rosin Dip Time: 4±1sec.				
Terminal Strength	The terminal electrode & the dielectric must	For Z / L Series :				
<u>Q</u> .	not be damaged by the forces applied on the	Size Force (Kfg) Time (sec)				
	right conditions.	1 0.2				
		2 0.5				
	→ W	3 0.6				
		4 1.0 > 25				
		5 1.0				
		6 1.0				
	₩ W	7 1.5				
		8 2.0				
Flexture Strength	The terminal electrode & the dielectric must not be damaged by the forces applied on the right conditions. 20(.787) Bending 45(1.772) 45(1.772) 40(1.575)	Solder a chip on a test substrate, bend the substrate by 2mm (0.079in) and return.				



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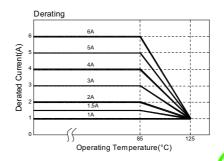
L4 SERIES

8. RELIABILITY & TEST CONDITION:

ITEM	PERFORMANCE		TEST CONDITION			
Bending Strength	The ferrite should not be damaged b	y forces	For Z / L Series	:		
	applied on the right condition.	Series name	mm (inches)	P-Kgf		
	R0.5(0.02) - 1.0(0.039))	2	0.80 (0.033)	0.3	
		٦	3	1.40 (0.055)	1.0	
			4	2.00 (0.079)	2.5	
	Chip Chip	7	5	2.00 (0.070)	2.0	
	A		6	2.70 (0.106)	2.5	
			7	2.70 (0.100)	2.0	
			8			
Random Vibration Test	Appearance: Cracking, shipping & a defects harmful to the characteristics not be allowed.	Frequency: 10-55-10Hz for 1 min. Amplitude: 1.52mm Directions & times: X, Y, Z directions for 2 hours. A period of 2 hours in each of 3 mutually perpendicular directions (Total 6 hours).				
Drop	Drop 10 times on a concrete floor from height of 75cm.	No mechanical damage				
Loading at High Temperature	Appearance : No damage. Inductance : Within ±10% of initial va Q : Within ±30% of initial value.	Temperature: 85±5°C Applied Current: rated current Duration: 1008±12hrs Measured at room temperature after placing for 2 to 3hrs.				
Humidity			Humidity: 90~9 Temperature: 4 Duration: 1008 Measured at ro	10±2°C	after placing fo	or 2 to 3hrs.
Thermal Shock	Appearance : No damage. Inductance : Within ±10% of initial value. Q : Within ±30% of initial value. Phase Temperature (°C) Times (min.) 1 -40±2°C 30±3 2 +85±5°C 30±3		For L Series: Condition for 1 cycle Step1: -40±2°C 30±3 min. Step2: +85±5°C 30±3 min. Number of cycles: 100 Measured at room temperature after placing for 2 to 3hrs			or 2 to 3hrs.
Low temperature storage test	Measured : 100 times	Temperature : -55±2°C Duration : 1008±12hrs Measured at room temperature after placing for 2 to 3hrs.			or 2 to 3hrs.	
Drop	Drop 10 times on a concrete floor from height of 75cm.	om a	No mechanical	damage		

Derating Curve

For the ferrite chip bead which withstanding current over 1.5A, as the operating temperature over 85°C, the derating current information is necessary to consider with. For the detail derating of current, please refer to the Derated Current vs. Operating Temperature curve.



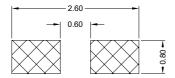
RoHS Compliant

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9. SOLDERIND AND MOUNTING:

9-1. Recommended PC Board Pattern



PC board should be designed so that products are not sufficient under mechanical stress as warping the board. Products shall be positioned in the sideway direction against

the mechanical stress to prevent failure.

9-2. Soldering

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

9-2.1 Lead Free Solder Re-flow:

Recommended temperature profiles for re-flow soldering in Figure 1.

9-2.2 Solder Wave:

Wave soldering is perhaps the most rigorous of surface mount soldering processes due to the steep rise in temperature seen by the circuit when immersed in the molten solder wave, typical at 230°C. Due to the risk of thermal damage to products, wave soldering of large size products is discouraged. Recommended temperature profile for wave soldering is shown in Fig. 2

9-2.3 Soldering Iron (Figure 3):

Products attachment with soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended. Note:

- a) Preheat circuit and products to 150°C.
- b) 350°C tip temperature (max)
- c) Never contact the ceramic with the iron tip
- d) 1.0mm tip diameter (max)
- e) Use a 20 watt soldering iron with tip diameter of 1.0mm
- f) Limit soldering time to 3 secs.

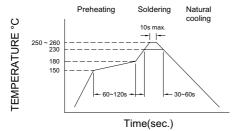


Figure 1. Re-flow Soldering

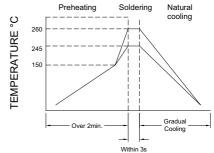


Figure 2. Wave Soldering

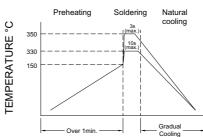


Figure 3. Hand Soldering

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9-3. Solder Volume

Accordingly increasing the solder volume, the mechanical stress to product is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance. Solder shall be used not to be exceed as shown in Fig. 4.

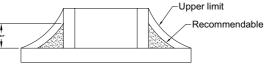


Figure 4

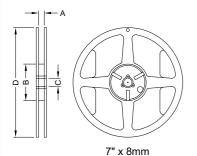


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10. PACKAGING INFORMATION:

10-1. Reel Dimension



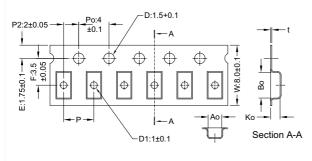


Туре	A(mm)	B(mm)	C(mm)	D(mm)
7" x 8mm	9.0±0.5	60.0±2.0	13.5±0.5	178.0±2.0
7" x 12mm	13.5±0.5	60.0±2.0	13.5±0.5	178.0±2.0

7" x 12mm

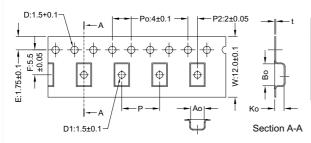
2±0.5 — 13.5±0.5 R1.9 — R0.5

10-2 Tape Dimension / 8mm



Series	Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
	1	1.12±0.05	0.67±0.05	0.54±0.05	2.0±0.1	0.23±0.05	none
	2	1.80±0.10	1.01±0.10	1.02±0.10	4.0±0.1	0.22±0.05	none
Z/L	3 (09)	2.25±0.10	1.42±0.10	1.04±0.10	4.0±0.1	0.22±0.05	1.0±0.1
	3 (12)	2.35±0.10	1.50±0.10	1.45±0.10	4.0±0.1	0.22±0.05	1.0±0.1
	4	3.50±0.10	1.88±0.10	1.27±0.10	4.0±0.1	0.22±0.05	1.0±0.1
	5	3.42±0.10	2.77±0.10	1.55±0.10	4.0±0.1	0.22±0.05	1.0±0.1

10-2.1 Tape Dimension / 12mm



Series	Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
	6	4.95±0.1	1.93±0.1	1.93±0.1	4.0±0.1	0.24±0.05	1.5±0.1
Z/L	7	4.95±0.1	3.66±0.1	1.85±0.1	8.0±0.1	0.24±0.05	1.5±0.1
	8	6.10±0.1	5.40±0.1	2.00±0.1	8.0±0.1	0.30±0.05	1.5±0.1

10-3. Packaging Quantity

Chip Size	8	7	6	5	4	3 (12)	3 (09)	2	1
Chip / Reel	1000	1000	2000	2500	3000	2000	4000	4000	10000
Inner Box	4000	4000	8000	12500	15000	10000	20000	20000	50000
Middle Box	20000	20000	40000	62500	75000	50000	100000	100000	250000
Carton	40000	40000	80000	125000	150000	100000	200000	200000	500000
Bulk (Bags)	7000	12000	20000	30000	50000	100000	150000	200000	300000



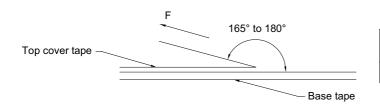
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10-4. Tearing Off Force



The force for tearing off cover tape is 15 to 60 grams in the arrow direction under the following conditions.

Room Temp.	Room Humidity	Room atm	Tearing Speed (mm/min)
(°C)	(%)	(hPa)	
5~35	45~85	860~1060	300

Application Notice

1. Storage Conditions:

To maintain the solderability of terminal electrodes :

- a) Temperature and humidity conditions : $10 \sim 40$ °C and $30 \sim 70$ % RH.
- b) Recommended products should be used within 6 months from the time of delivery.
- c) The packaging material should be kept where no chlorine or sulfur exists in the air.

2. Transportation:

- a) Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- b) The use of tweezers or vacuum pick up is strongly recommended for individual components.
- c) Bulk handling should ensure that abrasion and mechanical shock are minimized.



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